

Publication

EP 0871973 A4 19981021

Application

EP 96904583 A 19960131

Priority

- US 9601641 W 19960131
- US 38688495 A 19950210

Abstract (en)

[origin: WO9625024A1] The x-ray source of the present invention comprises a charged particle beam generator (112) and a vacuum enclosure assembly (176). The charged particle beam generator includes only a single electrical connection (803) for providing high voltage to the electron gun. The generated charged particle beam is controlled through a series of dynamic and static focus coils (187, 185) and moved across the inner face of the target (50) by a stepping coil assembly comprising X and Y deflection coils (190) as well as an X step and preferably Y step coils (188). Further, to minimize power usage a control grid pinches off the charged particle beam during the stepping of the beam.

IPC 1-7

H01J 35/00

IPC 8 full level

H05G 1/00 (2006.01); **A61B 6/00** (2006.01); **H01J 35/14** (2006.01); **H01J 35/30** (2006.01); **H05G 1/10** (2006.01); **H05G 1/52** (2006.01)

CPC (source: EP US)

H01J 35/153 (2019.05 - EP US); **H01J 35/30** (2013.01 - EP); **H05G 1/10** (2013.01 - EP)

Citation (search report)

- [XY] US 4206356 A 19800603 - DAVIS GORDON P [GB], et al
- [DY] US 4730350 A 19880308 - ALBERT RICHARD D [US]

Designated contracting state (EPC)

AT BE CH DE DK ES FR GB GR IE IT LI LU MC NL PT SE

DOCDB simple family (publication)

WO 9625024 A1 19960815; AT E241856 T1 20030615; AU 4865196 A 19960827; DE 69628454 D1 20030703; DE 69628454 T2 20040506; EP 0871973 A2 19981021; EP 0871973 A4 19981021; EP 0871973 B1 20030528; IL 116961 A0 19960514; IL 116961 A 20000229; JP H11504750 A 19990427

DOCDB simple family (application)

US 9601641 W 19960131; AT 96904583 T 19960131; AU 4865196 A 19960131; DE 69628454 T 19960131; EP 96904583 A 19960131; IL 11696196 A 19960130; JP 52439996 A 19960131